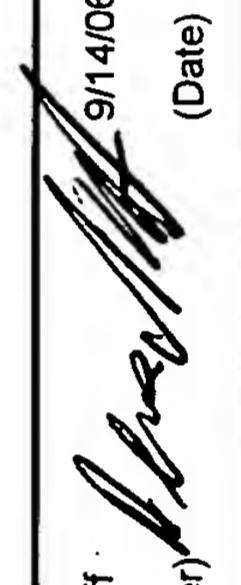


|  |  |                                  |      |  |                           |
|--|--|----------------------------------|------|--|---------------------------|
| <b>Issue Classification</b>  |  | Application/Control No. 10620948 |      | Applicant(s)/Patent under Reexamination KOUNO ET AL. |                           |
| <br>Examiner Markoff, Alexander               |  | Art Unit 1746                    |      |  |                           |
| <b>ORIGINAL</b>  |  |                                  |      |  |                           |
| <b>INTERNATIONAL CLASSIFICATION</b>  |  |                                  |      |  |                           |
| <b>CLASS</b>   |  | <b>SUBCLASS</b>                  |      | <b>CLAIMED</b>                                       |                           |
|  |  |                                  |      | B 0 8 B 1 / 02                                       | B 0 8 B 1 / 04            |
| 15   |  | 88.2                             |      | B 0 8 B 1 / 04                                       |                           |
| <b>CROSS REFERENCE(S)</b>  |  |                                  |      |  |                           |
| <b>CLASS</b> <b>SUBCLASS (ONE SUBCLASS PER BLOCK)</b>  |  |                                  |      |  |                           |
| 15   |  | 77                               | 97.1 | 102  |                           |
| 134  |  | 6                                | 902  |  |                           |
| <b>NON-ELECTRONIC DRAWINGS</b>   |  |                                  |      |  |                           |
| NONE<br>(Assistant Examiner)   |  |                                  |      | <b>Total Claims Allowed:</b><br>10                   |                           |
| <br>Alexander Markoff<br>(Primary Examiner) |  |                                  |      | O.G.<br>Print Claim(s)<br>2                          | O.G.<br>Print Figure<br>1 |
| <b>EXAMINER SIGNATURE</b>  |  |                                  |      |  |                           |
| <br>Alexander Markoff<br>(Primary Examiner) |  |                                  |      |  |                           |